

Performing Cyclic Voltammetry Measurements Using Model 2450 or 2460 SourceMeter[®] SMU Instruments

Chemical engineers, chemists, and other scientists use electrical measurement techniques to study chemical reactions and dynamics. Cyclic voltammetry (CV), a type of potential sweep method, is the most commonly used measurement technique. CV involves sweeping an electrode potential linearly as a function of time and measuring the resulting current that flows through the circuit, which is typically a 3-electrode electrochemical cell. The resulting I-V data provides important electrochemical properties about the analyte under investigation.

Cyclic voltammetry measurements are typically performed using a potentiostat, an often-used electrochemical measurement instrument. A Keithley Model 2450 or Model 2460 SourceMeter SMU Instrument can be used as an alternative for performing cyclic voltammetry and other electrochemistry tests, including use as a general-purpose lab tool for basic sourcing and measurement functions. These SourceMeters are programmable and can source and measure both current and voltage. They also allow users to plot the I-V results and save data without an external computer controller.

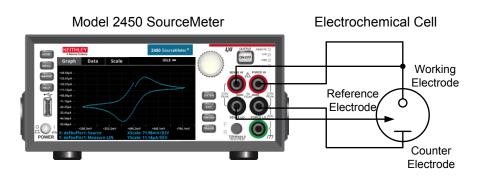


Figure 1. Model 2450 SourceMeter SMU Instrument plotting a voltammogram

This application note outlines using a Model 2450 or 2460 to perform cyclic voltammetry measurements with the Model 2450-ECHEM Electrochemical Test Suite option. This option is provided as a USB drive with a test script that can be downloaded and run directly on the SourceMeter to perform a CV test; it also has LabVIEW[®] code for performing cyclic voltammetry.





Application Note

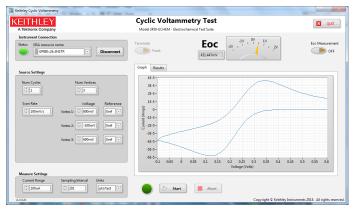


Figure 2. LabVIEW application for cyclic voltammetry

The CV test script has adjustable parameter settings and supports real-time plotting of a voltammogram on the SourceMeter's display. The user inputs the test parameters through a series of pop-up menus that appear on the display. After the test is executed, the data is stored to a USB drive inserted in the instrument's front panel. **Figure 1** shows a voltammogram plotted on the display of a Model 2450 using the cyclic voltammetry test script.

The LabVIEW code allows the user to enter test parameters easily and interactively, plot the voltammogram to the screen in real time, and save the results to the computer in a .csv file. For users that don't have LabVIEW available, the Model 2450-ECHEM option also includes a LabVIEW Run-Time application for performing the CV test from a PC. **Figure 2** shows the LabVIEW application for cyclic voltammetry. The code also allows taking continuous open-circuit voltage measurements.

The Basics of Cyclic Voltammetry

Figure 3 illustrates a typical electrochemical measurement circuit made up of an electrochemical cell, an adjustable voltage source (V_S), an ammeter (A_M), and a voltmeter (V_M). The three electrodes of the electrochemical cell are the working electrode (WE), reference electrode (RE), and the counter (or auxiliary) electrode (CE). The voltage source (V_S) for the potential scan is applied between the working electrode and the counter electrode. The potential (E) between the reference electrode and the working electrode is measured with the voltmeter, and the overall voltage (V_s) is adjusted to maintain the desired potential at the working electrode with respect to the reference electrode. The resulting current (i) flowing to or from the working electrode is measured with the ammeter (A_M). This process is usually repeated for a range of E.

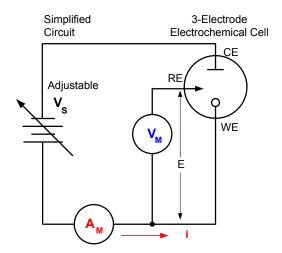


Figure 3. Simplified measurement circuit for performing cyclic voltammetry

The following procedure can be used to perform a measurement for each point in the scan, E(i):

- 1. Select a potential (E) for RE with respect to WE.
- 2. Adjust the voltage across the entire cell (CE to WE) to get desired E (closed loop control).
- 3. Measure i.
- 4. Select (step) a new E and repeat procedure until the scan is finished. The procedure can be a single sweep between two potentials. If this is the case, this is called linear sweep voltammetry. The procedure may also be configured that when a certain potential is reached, the sweep is inverted. This is called cyclic voltammetry. This cycle may be repeated multiple times during an experiment.
- 5. Plot the results and derive parameters of interest from the data.

Once the experiment is complete, the measured current is plotted as a function of the potential in a graph known as a voltammogram. The example voltammogram in **Figure 4** shows four voltage vertices: E1 (initial potential), E2 (second, switching potential), E3 (third, switching potential), and E4 (final potential). The voltage peaks in the waveform are the anodic (Epa) and the cathodic (Epc) peak potentials. In this example, the scan begins at E1 and the potential becomes increasing more positive causing the anodic current to rise rapidly and peak at the anodic peak potential (Epa). At E2, the scan direction switches to negative, cathodic current will flow as the electrode process is reduced. A cathodic peak potential occurs at Epc. At the third potential, E3, the direction

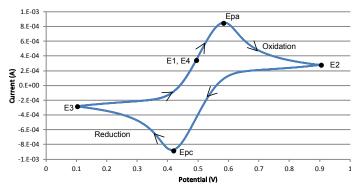


Figure 4. Example voltammogram generated using Model 2450 SourceMeter

is reversed again and the voltage is swept until it reaches E4. From the potential sweep, important information about the experiment can be derived and analyzed.

Using the Model 2450 or 2460 to Perform Cyclic Voltammetry

Follow these steps to perform cyclic voltammetry testing using the Model 2450 or 2460 and the CyclicVoltammetry test script included with the Model 2450-ECHEM option:

Make Connections from the 4-Terminal SourceMeter to the 3-Electrode Cell

To perform cyclic voltammetry using a SourceMeter, the instrument is set up to force voltage and measure current in a 4-wire (remote sense) configuration. The four terminals of the instrument are connected to the 3-electrode electrochemical cell, as shown in **Figure 5**.

The Force HI and Sense HI terminals are connected to the working electrode. At this terminal, the voltage is forced and the current is measured from the working electrode to the counter electrode. The Sense LO terminal is connected to the reference electrode. The Force LO terminal is connected to

the counter electrode. The instrument measures the voltage difference between the working and reference electrodes (between the Sense HI and Sense LO terminals) and ensures the voltage is kept constant.

When the instrument is programmed to source voltage in the remote sense configuration, internal sensing provides

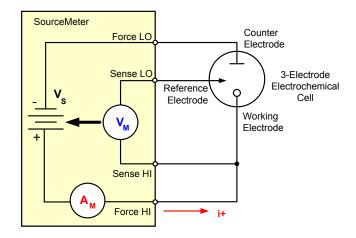


Figure 5. Connecting a SourceMeter to an electrochemical cell for cyclic voltammetry

a feedback voltage that is measured and compared to the programmed voltage level. If the feedback voltage is less than the programmed voltage level, then the voltage source is increased until the feedback voltage equals the programmed voltage level. Remote sensing compensates for the voltage drop in the test leads and analyte, ensuring that the programmed voltage level is delivered to the working electrode.

Download and Run the Test Script

Once the connections from the SourceMeter to the cell are made, the test script can be executed. The cyclic voltammetry test script was created using TSP® (Test Script Processing) code. TSP technology can embed complete test programs inside the instrument. Each SourceMeter has an embedded test script processor, which allows executing test programs (scripts), without the use of an external computer. Any editor, such as Notepad or Keithley's Test Script Builder software, can be used to edit a script.

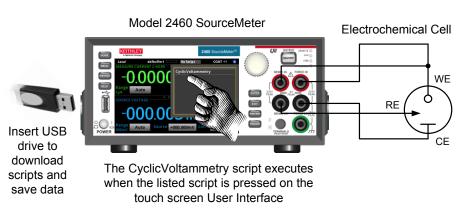


Figure 6. Executing the CyclicVoltammetry test script from the home screen of the Model 2460

Users can download and save the CyclicVoltammetry script into the SourceMeter via the front panel USB port or they can execute the test script directly from the USB drive. The test script is executed by pressing the Active Script Indicator at the top of the instrument's home screen, then touching the *CyclicVoltammetry* test script, as shown in **Figure 6**.

Execute the Test Script

Once the test script begins to execute, the user must respond to prompts on the instrument's touchscreen to define the parameters of the test.

Acquire the Open Circuit Potential: During execution, the measured open circuit potential (Eoc) is displayed and the user must respond if the value is acceptable. The open circuit potential of the electrochemical cell is measured while the instrument is in the voltmeter mode. When the open circuit potential is measured, the current source is set to output 0A. This high impedance voltage measurement is made using the instrument in a 4-wire configuration as shown in **Figure 7**. It's unnecessary to change any test leads manually.

This Eoc potential measurement can be used as the reference measurement when defining a voltage vertex. If this is the case, then the Eoc measurement gets added to that vertex.

Define the Voltage Vertices: After the open circuit voltage is measured, the voltages of the potential sweep must be defined, which includes the number of vertices, the voltage magnitude, and the reference voltage. The user can select up to four voltage vertices, which are defined as E1 (or E initial), E2, E3, and E4; these vertices are shown in the potential vs. time plot in **Figure 8**. The slope of the lines provides the scan rate that is used in the sweep.

The voltage magnitude in the range of $\pm 5.0000V$ must be specified for each vertex potential. The user must also choose if the applied potential at each vertex is vs. the reference potential (Eref) or the open circuit potential (Eoc).

Select the Scan Rate: Next, the scan rate is specified from a range of 0.1 mV/s to 3500 mV/s. The scan rate defines the rate at which the potential will be linearly swept during the experiment.

The instrument does not output a truly linear voltage; instead, it outputs very small digitized steps from 0.1mV to 10mV, depending upon the scan rate. These voltage step sizes are used during scanning based on the user-set scan rate:

- 100μ V Step Size: 0.1mV/s \leq scan rate < 35mV/s
- 1mV Step Size: $35mV/s \le scan rate < 350mV/s$
- 10mV Step Size: 350mV/s ≤ scan rate ≤ 3500mV/s

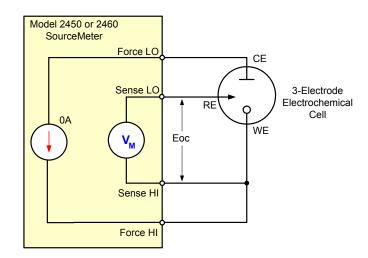


Figure 7. SourceMeter configuration for measuring the open circuit potential of an electrochemical cell

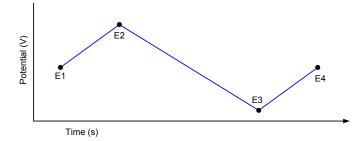


Figure 8. Potential sweep vs. time of cyclic voltammetry example

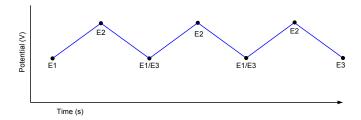


Figure 9. Graph of a three-cycle, three-vertex voltage scan

Select the Number of Cycles: The number of cycles selected (from 1 to 100) determines how many times each scan will be repeated. Figure 9 shows an example of a potential vs. time graph showing three cycles of a three-vertex voltage scan.

Choose a Current Measurement Range: During the scan, the current is measured on a user-specified range. The selectable current ranges will vary depending on whether the Model 2450 or Model 2460 is being used. The current ranges for the Model 2450 are the 10μ A, 100μ A, 1mA, 10mA, 100mA, and 1A ranges. The current ranges for the Model 2460 are the 1mA, 10mA, 100mA, 1A, 4A, 5A, and 7A ranges.

Sampling Interval Unit	Description	Range of Values		
pts/test	The total number of points acquired during a test regardless of how many cycles	10 to 10,000		
pts/cycle	The total number of points acquired in each cycle	10 to 10,000		
sec/pts	The number of seconds per each point	0.01 to 100		
pts/sec	The total number of points taken per second	0.01 to 100		
mV/pt	The number of millivolts between points	0.1 to 1000		
pts/mV	The number of points per millivolt	0.001 to 10		
mA/pt	The number of milliamps between points	0.0001 to 100		
pts/mA	The number of points per milliamp	0.01 to 10,000		

Table 1. Sampling Interval Units

Acquire Readings by Sampling Interval Units: During the scan, many small voltage steps are output and the resulting current is measured. To limit the number of points (current, voltage, and time readings) returned to the internal buffer, the user can define how often to store readings into the default buffer by specifying one of the eight Sampling Interval Units. **Table 1** describes each of the Sampling Interval Units along with a range of values.

Generate the Scan and View the Graph in Real Time: Once all the inputs have been defined, the experiment begins. The generation of the voltammogram can be viewed in real time on the Graph screen. The graphs are plotted using the IUPAC (International Union of Pure and Applied Chemistry) convention, in which potentials become more positive along the x-axis. Anodic current is shown as positive on the y-axis, and the cathodic current is shown as negative on the y-axis.

The voltammogram generated by the Model 2450 shown in **Figure 10** is a result of a chemical reaction. In this example, four voltage vertices and a scan rate of 25mV/s were used to generate this voltammogram, which contains data from three cycles.

Another example experiment was performed on copper sulfate using the CyclicVoltammetry test script. In this example, cyclic voltammetry was used to plate copper on a graphite working electrode and then strip it back again. This chemical reaction was:

(reduction) $Cu^{2+} + 2e^- \rightarrow Cu$ (metallic) (oxidation) $Cu \rightarrow Cu^2 + 2e^-$

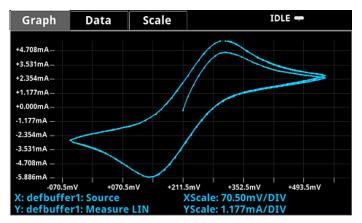


Figure 10. Voltammogram generated by Model 2450.

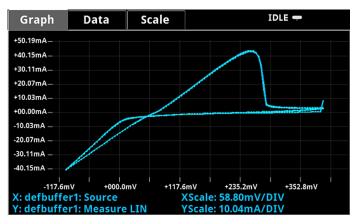


Figure 11. Voltammogram generated by Model 2450 for copper sulfate experiment

In this test, three voltage vertices were configured so the voltage was swept from $0.4V \rightarrow -0.1V \rightarrow 0.4V$ using a scan rate of 25mV/s. The Sampling Interval Unit was set to 5 points/s. Three cycles of the scan were performed and the results of this experiment are shown in **Figure 11**.

View the Results in the Data in the .CSV File: If the data is saved to the USB drive, the readings can be viewed by opening the file in a spreadsheet on a computer. **Figure 12** illustrates an example of how the data appears. In addition to the current, voltage, and time, general parameters about the test are included in the file.

General Paramete	rs:		
EOC potential =	0.215446	V	
fileName =	test7	-	
Source Parameter			
Source Range =	2		
# of Vertices =	4	V	
Vertex 1 =	0.215446	V	
Vertex 2 =	0.55	V	
Vertex 3 =	-0.05	V	
Vertex 4 =	0.215446	V	
Source Rate =	25	mV/sec	
# of Cycles =	3		
Measure Paramet			
Current Range =	0.1	A	
Sampling Interval	2	pts/sec	
Calculated Parame	eters		
stepSize =	V		
sourceDelay =		seconds	
, voltageLimit	0.55	V	
Current	Voltage	Seconds	
-0.000263035	0.21545	0	
0.00089106	0.22795	0.479199	
0.00181773	0.24045	0.979192	
0.00260912	0.25295	1.47921	
0.00328355	0.26545	1.97919	
0.00383069	0.27795	2.47919	
0.00423351	0.29045	2.9792	
0.00447714	0.30295	3.47921	
0.00456108	0.31545	3.97919	
0.00450899	0.32795	4.47918	

Using the LabVIEW Project and Library

The Model 2450-ECHEM Electrochemistry Test Suite contains a LabVIEW project for performing cyclic voltammetry and open circuit potential measurements. This option includes the LabVIEW source code to perform CV, as well as a LabVIEW Run-Time application to perform cyclic voltammetry from a PC for those using systems without LabVIEW installed.

Before executing the LabVIEW code, the Model 2450 or 2460 must be connected to the PC via a communication interface, either GPIB, USB, or Ethernet. Once connected, users can easily input the source and measure test parameters (scan rate, voltage source and reference values, number of cycles, measurement range, sampling interval units, etc.) in the Source Settings and Measure Settings windows of the LabVIEW application. After the CV test is configured, all it takes to execute the test is a touch of the Start button. The voltammogram is plotted in real time on the Graph tab. The current, voltage and time measurements are listed in real time in the Results tab, as shown in **Figure 13**. This data, along with the test parameters, can be saved to the computer in a .csv file. The open circuit voltage (Eoc) can also be monitored independently of the cyclic voltammetry scan.

EITHLEY A Tektronix Company	Cyclic Voltammetry Test Model 2450-ECHEM - Electrochemical Test Suite						🛛 Q	
Instrument Connection Status VISA resource name GPIB0:18:JNSTR Disconnect	Terminals	_	OC	-zv	-1V , 0V , 1	V _ 2V	Eoc I	Measur
Source Settings	Graph Results Test Parameters				Test Data			
Num Cycles Num Vertices	Parameter	Value			Voltage	Current	Seconds	
÷1 •3	General Parameters	Teros.		iāl I	1.6200E+0	12.9205E-6	16.204549E+0	- 1
	FOC Potential	0.022869	v		1.6800F+0	13,2844F-6	16.804531E+0	- 1
	LOC FOUND	0.022000			1.7400E+0	13.6268E-6	17.404527E+0	- 1
Scan Rate Voltage Reference	Source Parameters:				1.8000F+0	13.95935-6	18.004537E+0	10
© 100mV/s Vertex 1: © 0V Eref •	Source Range	20.0	V		1,8600E+0	14.2754E-6	18.604526E+0	-01
The line line line line line line line lin	# of Vertices	3			1.9200F+0	14.5788F-6	19,204535E+0	
	Vectex 1	0	V		1.9800E+0	14,8658E-6	19.804578E+0	
Vertex 2: 3V Eref -	Vertex 2	3	V		2.0400E+0	15.1310E-6	20.404535E+0	
	Vertex 3	0	V		2.1000E+0	15.38968-6	21.004523E+0	
Vertex 3: 0V Eref	Source Rate	100	mV/Sec		2.1600E+0	15.6321E-6	21.604538E+0	
Vertex 3: Vertex	# of Cycles	1			2.2200E+0	15.8593E-6	22.204525E+0	
					2.2800E+0	16.0670E-6	22.804529E+0	
	Measure Parameters:				2.3400E+0	16.2675E-6	23.404523E+0	۲.
	Current Range	0.0001	A					
Measure Settings	Sampling Interval	101	pts/test	Y			Save D	lata
Current Range Sampling Interval Units								
100uA 101 pts/test •	Start		Abort					

Figure 13. Keithley cyclic voltammetry LabVIEW Project GUI

Figure 12. Example data as it appears in a .csv file

Conclusion

The Model 2450 and Model 2460 SourceMeter SMU Instruments are ideal tools for performing common electrochemistry tests. The Model 2450-ECHEM Electrochemical Test Suite option contains a test script for performing cyclic voltammetry that can be downloaded to the instrument and executed without the use of a computer. The Model 2450-ECHEM also includes LabVIEW code for performing cyclic voltammetry and open circuit potential measurements using a PC.

Cyclic Voltammetry Test Settable Values:

- Potential Range: ±5V
- Voltage Step Size During Ramping:
 - 100µV (0.1mV/s < scan rate < 35mV/s)
 - 1mV (35mV/s < scan rate < 350mV/s)
 - 10mV (350mV/s < scan rate < 3500mV/s
- Scan Rate: 0.1mV/s to 3500mV/s
- Current Measurement Range (full scale):
 - 2450: 100µA, 1mA, 10mA, 100mA, 1A
 - 2460: 1mA, 10mA, 100mA, 1A, 4A, 5A, 7A
- Number of Cycles: 1 to 100
- User Selectable Sampling Interval Units: Points/Test, Points/Cycle, Seconds/Point, Points/Second, mV/Point, Points/mV, mA/Point, Points/mA
- Maximum Number of Points: up to 100,000 readings

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